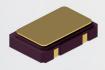


M53 SERIES

Crystal Oscillator | 3.3V | CMOS | 5x3.2mm Ceramic SMD | Military Grade



5x3.2 mm Ceramic SMD Package

Features

- **Ruggedized Design**
 - **High-Shock & Vibration**
- **Industry Standard Package**
- **Shortest Lead Time**
- **Smallest Hi-Rel Package**
- ECCN EAR 99
- **Robust Crystal Mount**
- **Best Stability Over Temperature**
- **Customer Support & Service**
- See M54 Datasheet for 5V Operation

Electrical SPECIFICATIONS

Dash No TriState	Number With TriStat	Range e	Supply Current @ 3.3V ±10%	Rise/Fall Time (tr/tf) max	Symmetry min / max	Aging per year max 1/	-55°C to +150°C	-55°C to +125°C	-55°C to +105°C	-40°C to +85°C
		(MHz)	(mA)	(nsec)	(%)	(ppm)	(ppm)	(ppm)	(ppm)	(ppm)
CODE	CODE						CODE H	CODE	CODE B	CODE
10	11	20 to 29.9	10	4	45/55	±10	±75	±65	±50	±40
12	13	30 to 39.9	10	3	40/60	±10	±75	±65	±50	±40
14	15	40 to 40.9	15	3	40/60	±10	±75	±65	±50	±40
16	17	50 to 60	15	2	40/60	±10	±75	±65	±50	±40

Please Contact Us for Specification Options that are Outside of or beyond those Shown in the Table Above

CMOS Output, 10 kΩ || 15 pF Load Output Voltage - Logic "0" is Vcc x 0.1 Vdc Output Voltage - Logic "1" is Vcc is 0.9 Vdc Start-up Time: 10 msec max

1/ Frequency Aging Limits

Max change over 30 days	±1.5 ppm
Max change over 90 days	±3 ppm

Pin Number	Function			
1	No Connect or TriState Enable			
2	Ground (case)			
3	Output			
4	Supply V (Vcc)			

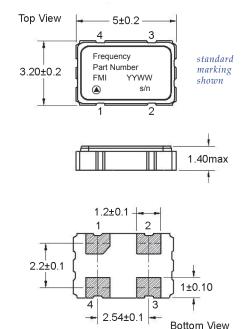
Standard PIN CONFIGURATION

How To ORDER

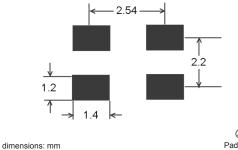
MIL-STD-790 Certified QPL per MIL-PRF-55310 ISO 9001:2015 Pb-free RoHS Certified



Mechanical SPECIFICATIONS



Recomended Land Pattern



Pad 1. ESD Symbol



Screening, B & C LEVELS					
Screening	Method Level:	В			
Non-Destruct Bond Pull	MIL-STD-883, Method 2023	•	•		
Internal Visual	MIL-STD-883, Method 2017, Class H; Method 2032, Class H	•	•		
Stabilization (Vacuum) Bake	MIL-STD-883, Method 1008, Condition C, 150°C, 24 hours min				
Temperature Cycling	MIL-STD-883, Method 1010, Condition B				
Constant Acceleration	MIL-STD-883, Method 2001, Condition A (Y1 only, 5000 g's)				
Seal: Fine Leak	MIL-STD-883, Method 1014, Condition A1				
Seal: Gross Leak	MIL-STD-202, Method 112, Condition D				
Electrical Test	Functional Test Only				
Marking & Serialization	MIL-STD-1285				
Electrical Test	Nominal Vcc & Extremes and Nominal Temp and Extremes				
Burn-in (no-load)	+125°C, Nominal Supply Voltage and Burn-in load, 48 hours min				
Burn-in (load)	+125°C, Nominal Supply Voltage and Burn-in load, 160 hours min				
External Visual & Mechanical	MIL-STD-883, Method 2009.10				
Final Electrical Test a) Input current, output frequency, output waveform, are tested at +23°C ±2°C b) Frequency stability is tested over the specified temperature range; at both extremes and at +25°C at a minimum of 5 temperature increments note: Recording of test data is by lot # and then serial #					

note: other screening levels and custom test plans available.



Features

- Ruggedized Design
- High-Shock & Vibration
- Made in the USA
- ECCN EAR 99
- Industry Standard Packages
- Highest Temperature Ranges
- Wider Frequency Ranges
- Higher Reliability
- Smaller Packages
- Lowest Current
- Best Service

Applications

- Mobile and Stationary Systems
- Aircraft Engine
- Radar DSP
- Vision Systems
- Aircraft Control
- Position Sensors
- Drone

- Smart Ammunition
- Deep Space Robotic
- Navigation Systems
- Guidance Systems
- Short & Long Earth Orbit Missions
- Commercial Satellites
- Reusable Rockets

Environmental COMPLIANCE						
Environmental	Specification	Method Condition				
Vibration – Sine	MIL-STD-202	Method 204	Condition D	20g, 10 to 2 KHz		
Vibration – Random	MIL-STD-202	Method 214	Condition 1	30g rms, 10 to 2 KHz Random		
Shock	MIL-STD-202	Method 213	Condition I	100g, 6 ms, F:1500, 0.5 ms		
Seal Test	MIL-STD-883	Method 1014	Condition A1	Fine Leak		
Seal Test	MIL-STD-883	Method 1014	Condition C1	Gross Leak		
Temperature Cycling	MIL-STD-883	Method 1010	Condition B	10 Cycles Minimum		
Constant Acceleration	MIL-STD-883	Method 2001	Condition A	5000g, Y1 Axis		
Thermal Shock	MIL-STD-202	Method 107	Condition B			

continued...

Environmental	Specification	Method	Condition
Ambient Pressure	MIL-STD-202	Method 105	Condition C
Resistance to Soldering Heat	MIL-STD-202	Method 210	Condition C
Moisture Resistance	MIL-STD-202	Method 106	with 7B Sub-cycle
Salt Atmosphere	MIL-STD-883	Method 1009	Condition A (24 hrs)
Terminal Strength	MIL-STD-202	Method 211	Test Condition D
Solderability	MIL-STD-883	Method 2003	
Resistance to Solvents	MIL-STD-202	Method 215	

MIL-STD-790 Certified QPL per MIL-PRF-55310 ISO 9001:2015

Pb-free RoHS Certified

Military Reference Specifications

MIL-PRF-55310 Oscillators, Crystal Controlled, General Specification For
MIL-PRF-38534 Hybrid Microcircuits, General Specification For
MIL-STD-202 Test Method Standard, Electronic and Electrical Components
MIL-STD-1686 Test Methods and Procedures for Microelectronics
MIL-STD-1686 Electrostatic Discharge Control Program for Protection of

Electrical and Electronic Parts, Assemblies and Equipment

Materials

- 1. Package Materials: Ceramic, Alumina 90% min
- 2. Pad Plating Material: Gold Plate 0.3 μm (12 μ inch) over 2 μm (80 μ inch) min. Nickel

Products for Military Applications

Contact us for assistance with your specification. We will provide you with the technical support and the required documentation.

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